

Search Notes

Application/Control No.

10/064,016

Examiner

Hai H. Huynh

Applicant(s)/Patent under
Reexamination

BIDNER ET AL.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
123	329	8/23/2005	HHH
123	406.53	8/23/2005	HHH
123	406.72	8/23/2005	HHH
123	406.47	8/23/2005	HHH
123	443	8/23/2005	HHH
123	481	8/23/2005	HHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	8/23/2005	HHH